

<b>Notice of References Cited</b>	Application/Control No. 10/067,304	Applicant(s)/Patent Under Reexamination FUJII ET AL.	
	Examiner Ba Huynh	Art Unit 2179	Page 1 of 1

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	B	US-6,772,393	08-2004	Estrada et al.	715/512
	C	US-			
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**NON-PATENT DOCUMENTS**

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